Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10660683	EBISAWA, TAKASHI
Examiner	Art Unit
Patel, Jayesh A	2624

SEARCHED					
Class	Subclass	Date	Examiner		
382	273,275,274,271,266,264,263,256,258,266	01/22/07	JP		
358 462		06/17/07	JP		

SEARCH NOTES				
Search Notes	Date	Examiner		
See attached East Search History				
See attached east Search history	03/21/08	JP		
Consulted with SPE Matthew bella regarding making a 103.	03/21/08	JP		
Consulted with SPE Brian Werner regarding the 101 (see examiner's amendment)	09/24/08	JP		
Consulted with SPE Jingge Wu regarding the allowance.	09/24/08	JP		
See the updated East, Inspec and the Inventor search	09/26/08	JP		

INTERFERENCE SEARCH				
Class		Subclass	Date	Examiner
382	266		09/26/08	JP
358			09/26/08	JP

/J. A. P./ Examiner.Art Unit 2624	

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